Welcome to the Photovoltaic Statistical Laboratory

The Photovoltaic Statistical Laboratory conducts research on stochastics in photovoltaics, especially by developing new methods for statistical inference and analysis in photovoltaics. Current research focuses on problems arising in photovoltaic quality control and the evaluation of PV systems. We develop tailor-made sampling and inspection plans, monitoring procedures for photovoltaic systems and methods to analyse related data including high-dimensional data.

The lab brings together a unique mix of internationally recognised expertise in statistics, including quality control as well as a number of applied areas including optimal experimental design, time series analysis and change-point detection.

Link: Have a look at the [WIRED Space Photo of the Day 09/01/2014...](direct image link)
**PV-Scan: Project Results**

The main results from the collaborative research project PV-Scan were summarized in a joint paper which is published in PV-Tech Power (Volume 14). The main goal of this long-term study was to analyze and carefully evaluate selected photovoltaic systems, in order to assist the assessment of technical defects and faults as well as their bankability and risk assessment. The failure assessments based on data collected during the course of the project from 5 PV systems and additional data showed the importance of elective quality assurance.

Severy quality problems like "whitening" or "yellowing" of backsheets - an issue concerning the overall gigawatt range - and potential-induced degradation (PID) were studied and evaluated. A problem detected during the project was the unexpected amount of thermally damaged or destroyed interconnectors: Inspection of IR images revealed that up to 6% of the installed modules were affected by overheating junction boxes.

The evaluation of PV systems based on performance measurements and/or EL imaging requires to draw a sample from the system. The PV-StatLab team developed a novel cluster-sampling approach to minimize the costs of sampling. To monitor performance data collected by data loggers, specific monitoring schemes based on string-data were developed, examined and applied.

A further major contribution of the PV-StatLab team was the development of methods for automatized analysis of EL images of photovoltaic modules, see below.

For further information see [here](#).

**July 2017**

**Automatic Detection of Suspicious Areas in EL Images**

When current is fed into a solar cell, photons are emitted. In this way, electroluminescence inverts the usual operation of a solar cell, where electrons are excited by absorbed photons and travel through the silicon when the bandgap energy is exceeded, resulting in a flow of charge carriers (electrons and wholes) to the contacts. The emitted light, which can be captured by a specialized camera, is proportional to the voltage, such that poorly contacted or inactive cell areas show up as dark in an EL image.

PVStatLab and the stochastics research group have developed novel methods to detect automatically suspicious areas in electroluminescence (EL) images of solar cells and PV modules, which correspond to low-performing or high-performing cell areas. In this way, cell areas can be identified which may be causal for low-performing PV modules. The detection methods are designed as statistical hypothesis tests and therefore allows us to control the type I error probability of false detection.
Crop of an EL difference image of consecutive time instants of a cell with a break. The red cell area got worse, whereas the green one has improved in terms of radiative recombination.
Two different types of detectors have been developed and are currently under extensive testing and benchmarking with simulation models and real image data: The first approach aims at detecting suspicious cell areas in comparison to the overall mean intensity and therefore also allows to identify inhomogenous cell activity. Contrary, the second approach compares a cell area with its neighborhood and thus focuses on detecting local effects.

November 2016

Statistical Analysis of Photovoltaic Outdoor Measurements

Outdoor measurements taken at PV sites may be affected by various factors, which complicates their analysis and the evaluation of PV modules and systems. PVStatLab has developed a comprehensive statistical framework covering the sampling design as well as the statistical analysis. We propose to sample data in randomly located clusters of neighboring modules, in order to reduce costs, end up with data sets which contain the required statistical information and allow to conduct statistical inference. The proposed methodology allows for complex designs with stratification (to deal with different classes of modules), general (nested) correlation structures and avoids restrictive assumptions. The approach has been extensively investigated by computer simulations to gain insights into the detectability of differences between sites in the presence of spatial cluster correlations. By analyzing massive data derived from EL images collected in the PV-Scan study we found evidence for the presence of spatial correlations in such outdoor data.

The results have been published as an OpenAccess paper and are therefore available to the public. Read more...

November 2015

Award
Evegenii Sovetkin was awarded for his talk about "EL Image Analysis and Related Problems of Shape Statistics" presented at the 8th International Workshop on Simulation held in Vienna.

February 2015

**Preprocessing EL Image Field Data**

In order to reduce the costs of quality control in photovoltaics, one may take EL images of PV modules in the field. But then distortions such as radial or perspective distortion are much stronger as for EL images taken in a laboratory. We have developed sound and fast preprocessing methods, tailor-made for solar panels, which correct those distortions. For instance, in order to correct the perspective distortion, one has to determine the right angle in order to rotate the image appropriately. The automatic calculation of such an angle is, however, sensitive with respect to outliers, e.g. due to additional background objects. PVStatLab has developed a robust statistical approach to deal with that problem which has been successfully validated based on a large database of real EL images. The results are accepted for publication in the Proceedings of the *3rd International Conference on Mathematical, Computational and Statistical Sciences* and will be also part of plenary lecture of Prof. Steland given there.

January 2015

**Detecting Changes in Inhomogeneous EL Image Data**

Electroluminescence (EL) imaging has become a state-of-the-art technique to evaluate the physical state and quality of solar panels. We developed a new methodology in order to detect local changes, e.g. due to a damage, from a reference EL image in a sequence of EL images. The method allows to contrast a given focus region, where a defect may occur, with its neighborhood, thus allowing to take into account inhomogeneities as arising in multicrystalline solar cells. The theoretical results are accepted for publication in the volume *Stochastic Models, Statistics and Their Applications* that appears in the series Springer Proceedings in Mathematics and Statistics. The results will also be part of an invited talk given by PVStatLab researcher Annabel Prause.

The theory developed therein allows to design the procedure like a statistical significance test, such that signals indicating a defect come with a p-value resp. a significance level. That research has been partly conducted within the PV-Scan collaborative project. In addition, a more comprehensive methodology has been the subject of a recent Ph.D. thesis. Future planned work will focus on investigating, evaluating and comparing those approaches for real EL image data in order to propose a reliable procedure for practice.
July 2014

**PV-Scan is Energiewende-Project**

The PV-Scan project has been classified as an Energiewende project and thus has been assigned to the Federal Ministry for Economic Affairs and Energy.

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December 2013

**Mini-Workshop on Stochastics in Photovoltaics**

We are organizing a Mini-Workshop on *Stochastics in Photovoltaics* focusing on new acceptance sampling procedures, supported by the Society of Reliability, Safety and Quality and the PV-Scan Collaborative Research Project. The extension of acceptance sampling procedures to multi-period inspection-sampling plans belongs to the research goals of the lab. The main talk will be given by

Wolfgang Kössler (Humboldt University Berlin)

The mini-workshop will take place at the library of the Institute of Statistics and starts at 11:00. The main talk, being part of a series of invited lectures of the Institute of Statistics, will be held in lecture hall FO6 at 15:00. Read more.
BMU Funded Collaborative Research Project Starts

The Federal Ministry for the Environment, Nature Conservation and Nuclear Safety (BMU) has awarded a research grant to a large consortium including PVStatLab@RWTH (ISW, Chair of Stochastics), a research institute and industrial partners. More information will be provided soon. Read more (press statement).

New Control-Inspection Sampling Scheme to Lower Costs

The quality of solar panels used in a roof installation or larger solar plant, in particular the power output, can be substantially influenced by quality issues that may lead to a loss of power, either more or less instantly or on the long run. For example, modules may be damaged during transportation from the manufacturer to the site or due to wrong installation. Those pre-existing defects may be invisible by eye and have no effect on the electrical properties at the beginning, but some of them are under suspicion to contribute to early degradation of PV modules resulting in substantial power losses or even outages, as evidenced by recent empirical studies. For this reasons, the quality control should not only focus on control samples taken at the time of delivery of the modules, but should also comprise inspections at later time points.

PVStatLab @ RWTH has developed new statistical procedures that try to make a first step towards such extensions. The approach generalizes our acceptance sampling procedures that allow to base decisions on a minimal number of control samples, in order to cut costs of quality control. The new procedure aggregates information from the manufacturer, control samples taken at the time of construction of the PV system and from a further inspection sample. In this way, the costs of the inspection sample can be limited without affecting the statistical quality of the overall procedure. The results will be part of an invited talk to be given by Professor Steland at the International Workshop in Intelligent Statistical Quality Control at Sidney, Australia.

Download the preprint

July 2013
A central issue of the lab's research agenda of the last years, supported by a grant of the Federal Ministry of the Environment and Nuclear Safety, led us to studying a challenging open mathematical problem. We examined how Bernstein-Durrmeyer polynomial approximations, closely related to the well-known Bezier curves heavily used in computer science to reconstruct smooth curves and surfaces from sampling points, could be used to construct efficient quality control procedures for photovoltaics. A crucial issue is to select the degree of the polynomial in such a way that the estimator calculated from the random sample approaches the true value as the sample size gets larger. For Bernstein-Durrmeyer polynomial estimators this question remained an unsolved open mathematical problem.

We developed a novel data-adaptive rule to select the degree and were able to prove that the resulting estimator is consistent. The assumptions for this result are weak enough to guarantee its applicability to a wide range of photovoltaic applications and other areas of application as well. The results have been accepted for publication in the Journal of Nonparametric Statistics. The article also elaborates on the application of the results to the quality control of photovoltaic systems in the case that one cannot ensure large enough samples to control both the producer's and consumer's risk, and also analyzes real photovoltaic data.

September 2012

Research Publication

Results of our current research project will be published in Progress in Photovoltaics, a leading interdisciplinary high-impact journal (impact factor: 7.7). In that publication we describe a new theory to evaluate the reliability of solar panels by out-of-spec sampling plans and demonstrate its application in photovoltaic practice. Our new methodology may lead to substantially reduced sample sizes of control samples and therefore cuts the costs of photovoltaic quality assessments. The lab intends to implement the approach as a software tool to improve the reliability of solar panels.

June 2012

APOS photovoltaic StatLab is used by leading photovoltaic research laboratories and manufacturers. By providing such a software tool we foster dissemination and application of our research findings and are in a position to realize a fast-track technology transfer. Our new procedures may lead to a reduction of up to 80% in terms of the costs associated to quality control.
Invited Talk at ISI Conference, Dublin, UK

Professor Steland gave an invited talk at the *58th World Statistics Congress* organized by the International Statistical Institute and held at Dublin, covering selected research results. Those biennial ISI conferences represent the largest international meetings in the statistical science and cover theoretical as well as applied topics.

Current research projects are devoted to quality control of solar panels. Partners include SolarWorld AG, AVANCIS GmbH & Co KG and TÜV Rheinland Group.

The laboratory is interested in promoting collaboration with researchers at other universities through visits and organisation of workshops.